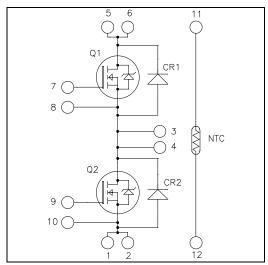
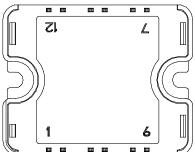


Phase leg <u>SiC MOSFET P</u>ower Module





Pins 1/2; 3/4; 5/6 must be shorted together

$$\begin{split} V_{DSS} &= 1200 V \\ R_{DSon} &= 17 m \Omega \text{ max } @. \text{Tj} = 25^{\circ} \text{C} \\ I_D &= 143 \text{A} . @. \text{Tc} = 25^{\circ} \text{C} \end{split}$$

Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- SiC Power MOSFET
 - Low R_{DS(on)}
 - High temperature performance

• SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_i = 25$ °C unless otherwise specified

1. SiC MOSFET characteristics (Per MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1200	V
Ţ	Continuous Drain Current	$T_c = 25^{\circ}C$	143	
I_D	Continuous Drain Current	$T_c = 80$ °C	108	Α
I_{DM}	Pulsed Drain current		280	
V_{GS}	Gate - Source Voltage		-10/+25	V
R_{DSon}	Drain - Source ON Resistance		17	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25^{\circ}C$	600	W

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 120$		20	200	μΑ	
D	Duning Common on Boninton	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		12.5	17	
R _{DS(on)}	Drain – Source on Resistance	$I_{\rm D} = 100 A$	$T_{j} = 150^{\circ}C$		22	32	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2mA$		1.9	2.3		V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1	μA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$			5960		
C_{oss}	Output Capacitance	$V_{\rm DS} = 1000V$	$V_{\rm DS} = 1000V$		440		pF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz			46		
Q_{g}	Total gate Charge	$V_{GS} = -2/+20V$			360		
Q_{gs}	Gate – Source Charge	$V_{\text{Bus}} = 800V$			64		nC
Q_{gd}	Gate – Drain Charge	$I_{\rm D} = 100 A$			126		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -2/+20V$			21		
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 800V$			19		
$T_{d(off)}$	Turn-off Delay Time	$I_{\rm D} = 100 A$			50		ns
T_{f}	Fall Time	$R_L = 8\Omega$; $R_G = 10\Omega$			30		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150^{\circ}C$		2.2		m I
$E_{\rm off}$	Turn off Energy	$I_{D} = 100A$ $R_{G} = 10\Omega$	$T_{j} = 150^{\circ}C$		1.2		mJ
R_{thJC}	Junction to Case Thermal Resistance	e				0.21	°C/W

2. SiC diode characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_j = 25^{\circ}C$ $T_i = 175^{\circ}C$		70 130	400 800	μΑ
I_{F}	DC Forward Current		$T_j = 173 \text{ C}$ $T_c = 125 \text{°C}$		40	800	A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 40A$ $\frac{T_i = 25^{\circ}C}{T_i = 175^{\circ}C}$			1.5	1.8	V
$Q_{\rm C}$	Total Capacitive Charge	$I_F = 40A, V_R = 1200V$ $di/dt = 1000A/\mu s$			260		nC
С	Total Capacitance $f = 1MHz, V_R = 200V$		$f = 1 \text{MHz}, V_R = 200 \text{V}$		186		pF
C	Total Capacitance	$f = 1 MHz, V_R = 400 V$			134		
R_{thJC}	Junction to Case Thermal Resistance	2				0.7	°C/W

2 – 6



3. Thermal and package characteristics

Package characteristics

Symbol	Characteristic		Min	Typ	Max	Unit		
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000			V	
т	Operating junction temperature range		SiC MO	SFET	-40		150	
T_{J}	Operating junction temperature range	SiC diode		-40		175		
T_{JOP}	Recommended junction temperature under switching conditions			-40		T_J max	°C	
1 JOP	Recommended junction temperature under switching conditions				-40		-25	
T_{STG}	Storage Temperature Range				-40		125	
$T_{\rm C}$	Operating Case Temperature				-40		125	
Torque	Mounting torque	To hea	atsink	M4	2		3	N.m
Wt	Package Weight				80	g		

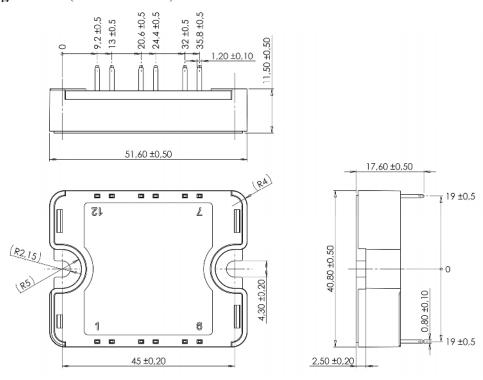
Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T _C =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_T: \text{ Thermistor value at T}$$

SP1 Package outline (dimensions in mm)

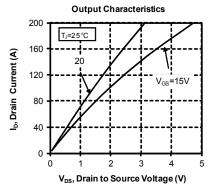


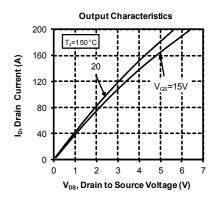
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

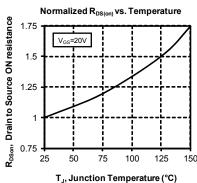


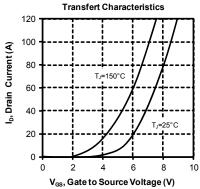
4. Typical Performance Curves

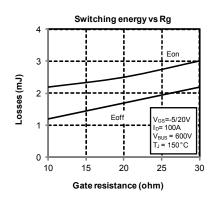
SiC MOSFET

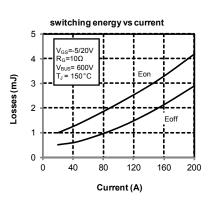


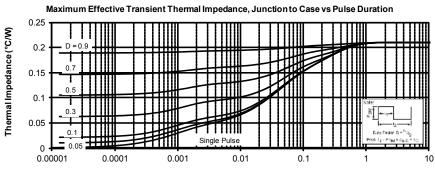






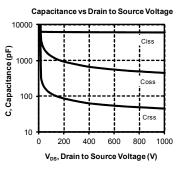


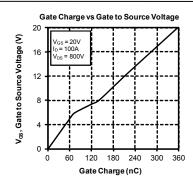


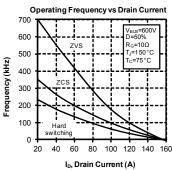


rectangular Pulse Duration (Seconds)

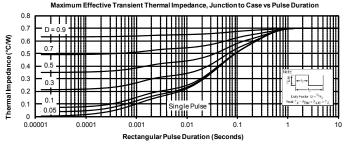


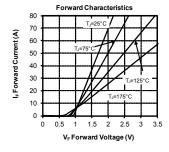


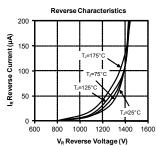


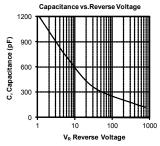


SiC diode









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